EFS-Web Receipt date: 04/27/2006 10595567 - GAU: 2825

Attorney's Docket No.: 12732-335US1 / PCTUS7477

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Kiyoshi Kato Art Unit: Unknown Serial No.: New Application Examiner: Unknown

Filed : April 27, 2006

Title : SEMICONDUCTOR INTEGRATED CIRCUIT AND DESIGN METHOD

THEREOF

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form.

Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

Submitted herewith is an English translation of the following foreign language references, or portions thereof:

Desig. ID	Source
AP	JP11-154169 - English Abstract : esp@cenet database - Worldwide (2006)

This statement is being filed with the application. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: April 27, 2006

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Substitute Form PTO-1449 U.S. Department of Commerce (Modified) Patent and Trademark Office				
Information Discl		Applicant Kiyoshi Kato		
(Use several sheet) (37 CFR §1.98(b))	ets if necessary)	Filing Date April 27, 2006	Group Art Unit	

Examiner Initial	Desig.	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
IIIIII	AA	2002/0083398 A1	06/27/2002	Takeyama et al.	Ciass	Jubulass	03/30/2001
	AB	2003/0009727 A1	01/09/2003	Takeyama et al.	-		09/09/2002
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	AF	5,705,829	01/06/1998	Miyanaga et al.			01/26/1996
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	slation
Initial	ID D	Number	Date	Patent Office	Class	Subclass	Yes	No
	AP	11-154169	06/08/1999	JAPAN			AB	
	AQ							

Other Documents (include Author, Title, Date, and Place of Publication)					
Examiner	Desig.				
Initial	ID.	Document			
	AR	Buyeol Lee et al.; "A CPU on a Glass Substrate Using CG-Silicon TFTs"; ISSCC 2003 / Session 9 / TD: Digital Architecture and Systems / Paper 9.4(Digest of Technical Papers) – IEEE International Solid-State Circuits Conference Vol. 1; pp. 164-165; February 11, 2003			
_	AS	David Van Campenhout et al.; "Timing Verification of Sequential Dynamic Circuits"; IEEE Transactions of Computer-Aided Design of Integrated Circuits and Systems, Vol. 18, No. 5; pp. 645-658; May 1999			
	AT	International Search Report (Application No. PCT/JP2004/016174) dated January 25, 2005			

Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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10595567 - GAU: 2825 Sheet <u>2</u> of <u>2</u>

Substitute Form PTO-1449 U.S. Department of Commerce (Modified) Patent and Trademark Office		Attorney's Docket No. 12732-335US1	Application No.
	closure Statement	Applicant Kiyoshi Kato	
(Use several si	neets if necessary)	Filing Date April 27, 2006	Group Art Unit

Other Documents (include Author, Title, Date, and Place of Publication)					
Examiner	Desig.	Danimant			
Initial	טו	Document			
	AU	Written Opinion (Application No. PCT/JP2004/016174) dated January 25, 2005			

Examiner Signature	/Magid Dimyan/	Date Considered	04/07/2008
EXAMINER: Initials citatio next communication to app		if not in conformance and	f not considered. Include copy of this form with